

Notice of References Cited

Application/Control No.

10/634,874

Applicant(s)/Patent Under
Reexamination
HABIBI ET AL.

Examiner

MCDIEUNEL MARC

Art Unit

3664

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,024,280	04-2006	Parker et al.	700/245
	B	US-			
	C	US-			
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	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number	Date	Country	Name	Classification
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*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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